

2470 Graphical SourceMeter® SMU Instrument Data Sheet

Datasheet



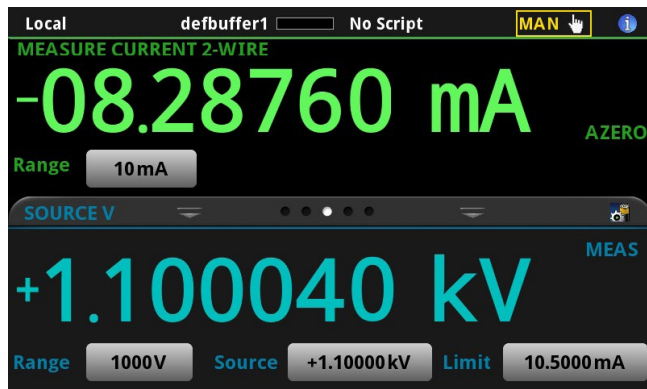
The 2470 High Voltage SourceMeter® Source Measure Unit (SMU) Instrument brings advanced Touch, Test, Invent® technology right to your fingertips. It combines an innovative graphical user interface (GUI) with capacitive touchscreen technology to make testing intuitive and minimize the learning curve to help engineers and scientists learn faster, work smarter, and invent easier. With its 1100 V and 10 fA capability, the 2470 is optimized for characterizing and testing high voltage, low leakage devices, materials, and modules, such as silicon carbide (SiC), gallium nitride (GaN), power MOSFETs, transient suppression devices, circuit protection devices, power modules, batteries, and much more. These new capabilities, combined with Keithley's decades of expertise in developing high precision, high-accuracy SMU instruments, make the 2470 a "go-to instrument" for high-voltage source and low-current measurement applications in the lab and in the test rack.

Key Features

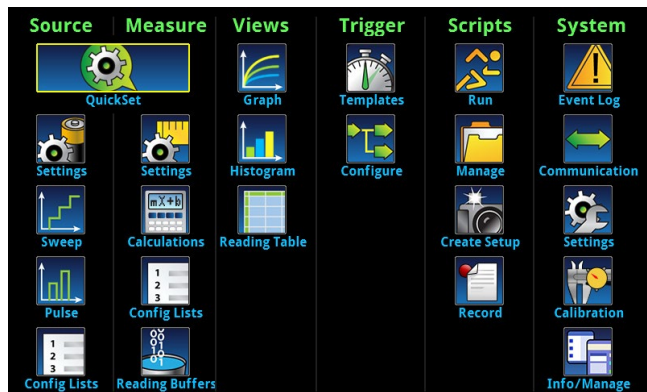
- Wide coverage up to 1100 V / 1 A DC 20 W max.
- 10 fA measure resolution
- 0.012% basic measure accuracy with 6½-digit resolution
- Five-inch, high resolution capacitive touch screen GUI
- Source and sink (4-quadrant) operation
- SCPI and TSP® scripting programming modes
- TSP-Link for multi-channel I-V testing
- Front panel input banana jacks; rear panel high-voltage input triaxial connections
- Built-in context-sensitive help
- Front-panel USB 2.0 memory I/O port for transferring data, test scripts, and test configurations

Learn Faster; Work Smarter; Invent Easier

The 2470 features a five-inch, full-color, high resolution touchscreen that supports intuitive operation, helps operators become familiar with the instrument quickly, and optimizes overall speed and productivity. A simple icon-based menu structure reduces the number of steps required to configure a test by as much as 50 percent and eliminates the cumbersome multi-layer menu structures typically used on soft-key instruments. Built-in, context-sensitive help supports intuitive operation and minimizes the need to review a separate manual. These capabilities, combined with the 2470's high versatility, simplify its operation in both basic and advanced measurement applications, regardless of the user's previous experience in working with SMU instruments.



2470 main home screen.

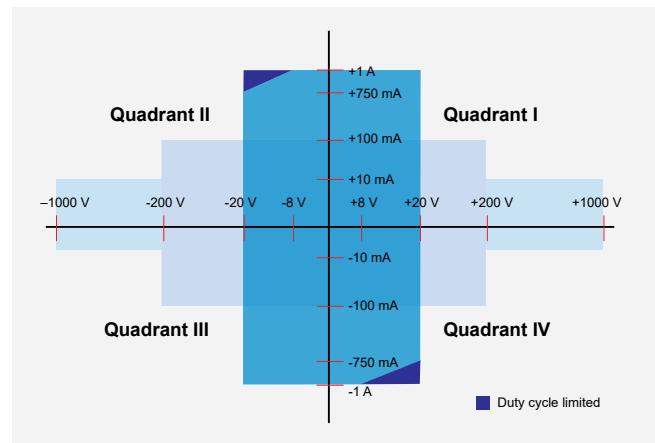


2470 icon-based menu.

All-in-One SMU Instrument

The 2470, Keithley's fourth generation of SourceMeter SMUs, leverages the proven capabilities of the original 2410 High Voltage SourceMeter SMU Instrument. SMU instruments offer a highly flexible, four-quadrant voltage and current source/load coupled with precision voltage and current measurements. This all-in-one instrument can be used as a:

- Precision power supply with V and I readback
- True current source
- Digital multimeter (DCV, DCI, ohms, and power with 6½-digit resolution)
- Precision electronic load
- Pulse generator
- Trigger controller



2470 power envelope.

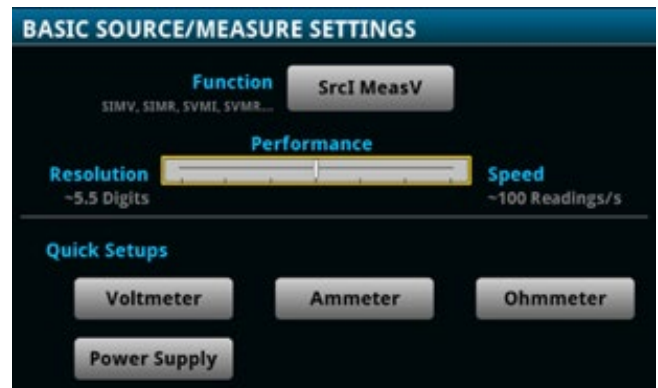


2470 front panel with high-resolution, capacitive touchscreen.

Ease of Use Beyond the Touchscreen

In addition to its five-inch color touchscreen, the 2470 front panel offers a variety of features that enhance its speed, user-friendliness, and learnability, including a USB 2.0 memory I/O port, a HELP key, a rotary navigation/control knob, a front/rear input terminal selector button, and banana jacks for basic bench applications. The USB 2.0 memory port simplifies storing test results and instrument configurations, uploading test scripts into the instrument, and installing system upgrades. All front-panel buttons are backlit to enhance visibility in low-light environments.

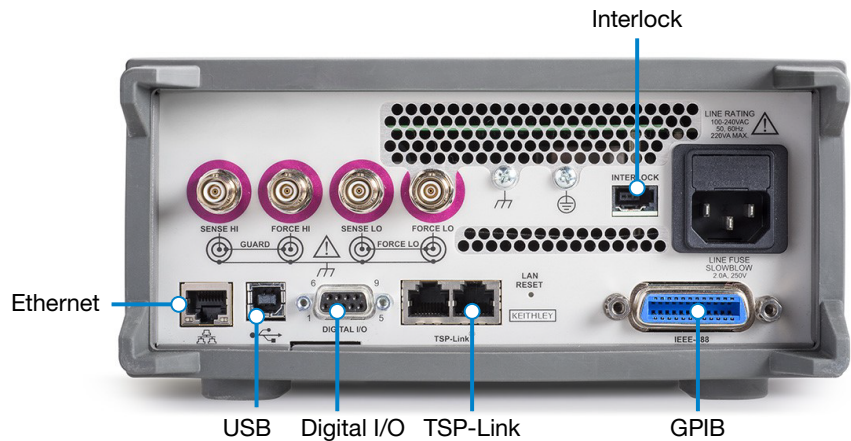
Four Quick Setup modes simplify instrument setup. With one touch, the instrument can be quickly configured for various operating modes without the need to configure the instrument indirectly for this operation.



One-touch Quickset modes speed measurement setups and minimize the time to measurements.

Comprehensive Built-in Connectivity

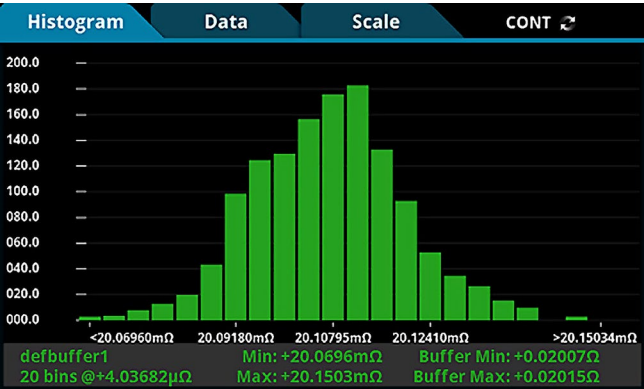
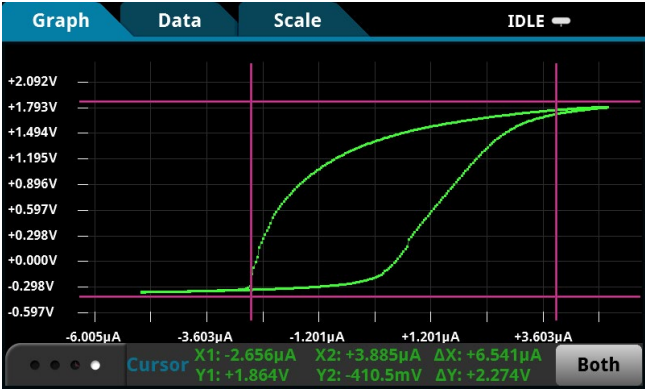
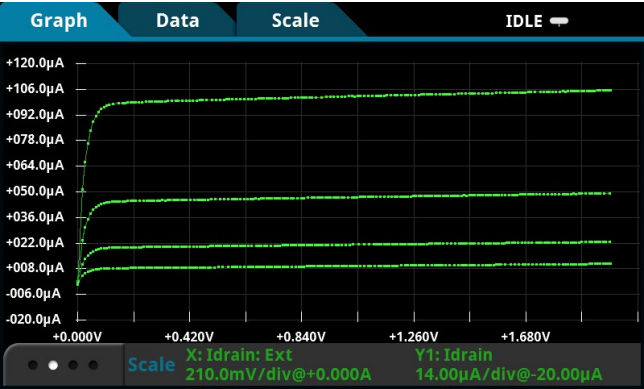
Rear panel access to rear-input connectors, remote control interfaces (GPIB, USB 2.0, and LXI/Ethernet), a D-sub 9-pin digital I/O port (for internal/external trigger signals and handler control), instrument interlock connector, and TSP-Link® connectors make it simple to configure multiple instrument test solutions and eliminate the need to invest in additional adapter accessories.



Rear panel connections are optimized for signal integrity and speed system setup.

Convert Raw Data to Information

A full graphical plotting window converts raw data and displays it immediately as useful information, such as semiconductor I-V curves and waveforms. Using the 2470's Sheet view, test data can also be displayed in tabular form. The instrument supports exporting data to a spreadsheet for further analysis, dramatically improving productivity for research, benchtop testing, device qualification, and debugging.



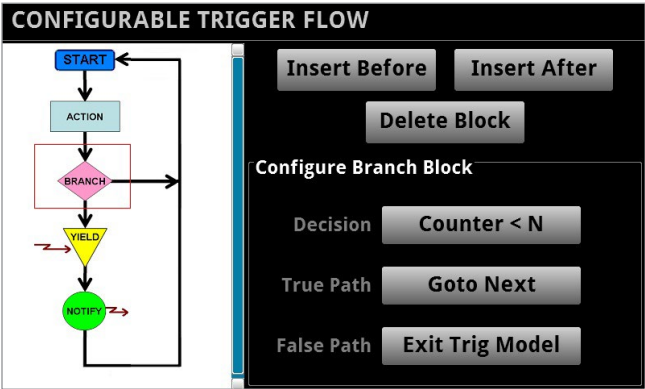
| READING TABLE | | | |
|----------------------------|-----------------------|-------------|------------|
| Buffer Active (defbuffer1) | | | |
| Buffer Index | Time | Source | Reading |
| 1 | 04/14 12:56:46.766230 | +6.000000 A | +5.98635 V |
| 2 | 04/14 12:56:46.770194 | +6.000000 A | +5.98594 V |
| 3 | 04/14 12:56:46.774216 | +6.000000 A | +5.98594 V |
| 4 | 04/14 12:56:46.778194 | +6.000000 A | +5.98594 V |
| 5 | 04/14 12:56:46.782211 | +6.000000 A | +5.98580 V |
| 6 | 04/14 12:56:46.786198 | +6.000000 A | +5.98649 V |
| 7 | 04/14 12:56:46.790208 | +6.000000 A | +5.98566 V |
| 8 | 04/14 12:56:46.794203 | +6.000000 A | +5.98484 V |
| 9 | 04/14 12:56:46.798219 | +6.000000 A | +5.98594 V |
| 10 | 04/14 12:56:46.802194 | +6.000000 A | +5.98566 V |

Built-in data display, charting, and spreadsheet export functions simplify converting test results into useful information.

TriggerFlow® Building Blocks for Instrument Control and Execution

The 2470 incorporates Keithley's TriggerFlow triggering system, which provides user control of instrument execution. TriggerFlow diagrams are created in much the same way that flow charts are developed, using four building blocks:

- Wait – Waits for an event to occur before the flow continues
- Branch – Branches when a condition has been satisfied
- Action – Initiates an action in the instrument, for example, measure, source, delay, set digital I/O, etc.
- Notify – Notifies other equipment that an event has occurred



TriggerFlow building blocks allow creating triggering models that range from very simple to highly complex.

A TriggerFlow model using a combination of these building blocks can be created from the front panel or by sending remote commands. With the TriggerFlow system, users can build triggering models from very simple to complex with up to 255 block levels. The 2470 also includes basic triggering functions, including immediate, timer, and manual triggering.

Unmatched System Integration and Programming Flexibility

When a 2470 is configured into a multi-channel I-V test system, its embedded Test Script Processor (TSP®) allows it to run test scripts, so users can create powerful measurement applications with significantly-reduced development times. TSP technology also offers channel expansion without a mainframe. Keithley's TSP-Link® channel expansion bus can connect multiple 2470s and other TSP instruments, including Keithley's other graphical SourceMeter instruments (2450, 2460, 2461), Keithley's DMM7510, DMM6500, and DAQ6510 graphical multimeters, Series 2600B System SourceMeter SMU instruments, and Series 3700A Switch/Multimeter systems, in a master-subordinate configuration that operates as one integrated system. The TSP-Link expansion bus supports up to 32 units per GPIB or IP address, making it easy to scale a system to fit an application's particular requirements.

Parallel Test Capability

The TSP technology in the 2470 supports testing multiple devices in parallel to meet the needs of device research, advanced semiconductor lab applications, and even high throughput production test. This parallel testing capability allows each instrument in the system to run its own complete test sequence, creating a fully multi-threaded test environment. The number of tests that can be run in parallel on a graphical SourceMeter can be as high as the number of instruments in the system.

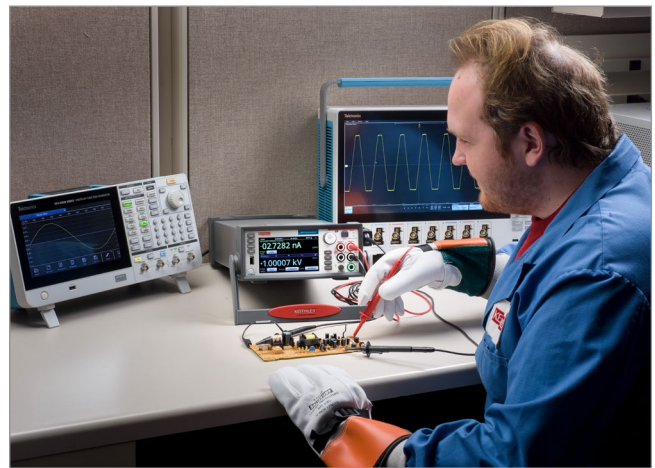


Characterize transistors with multiple SMU instruments on wafer or packaged transistors

Typical Applications

Ideal for current/voltage characterization and functional test of a wide range of today's modern electronics and devices, including:

- Devices
 - Power semiconductors and materials: SiC, GaN, power MOSFETs, power diodes
 - IGBT
 - Thyristors, SCRs
 - Transient suppression devices
 - Circuit protection devices: TVS, MOVs, fuses, etc.
 - Connectors, switches, relays
 - Power management modules
 - Batteries
- Tests
 - I-V characterization
 - Forward voltage
 - Breakdown voltage
 - Leakage current
 - Isolation
 - Hi-Pot
 - Dielectric withstanding



The 2470 is the ideal addition to your development bench for designing today's high power devices and components.

Instrument Control Start-up Software

KickStart instrument control/start-up software enables users to start making measurements in minutes without programming. In most cases, users merely need to make some quick measurements, graph the data, and store the data to disk for later analysis in software environments such as Excel. KickStart offers:

- Instrument configuration control to perform I-V characterization
- Native X-Y graphing, panning, and zooming
- Spreadsheet/tabular viewing of data
- Saving and exporting of data for further analysis
- Saving of test setups
- Screenshot capturing of graphs
- Annotating of tests
- Command line dialog for sending and receiving data
- HTML help
- GPIB, USB 2.0, Ethernet compliance

Simplified Programming with Ready-to-Use Instrument Drivers

For those who prefer to create their own customized application software, native National Instruments LabVIEW® drivers, and IVI-C and VICOM drivers are available at tek.com/keithley.



KickStart start-up software lets users be ready to make measurements in minutes.

Specifications

Voltage Specifications ^{1, 2}

| Range ⁴ | Source | | | Measure ³ | | |
|--------------------|------------|---|-----------------------|----------------------|------------------|--|
| | Resolution | Accuracy ⁵ 23 °C ± 5 °C, 1 Year ±(% setting + volts) | Noise (RMS) <10 Hz | Resolution | Input Resistance | Accuracy 23 °C ± 5 °C, 1 Year ±(% reading + volts) |
| 200.0000 mV | 5 µV | 0.015% + 200 µV | 2 µV | 100 nV | > 10 GΩ | 0.012% + 200 µV |
| 2.000000 V | 50 µV | 0.020% + 300 µV | 10 µV | 1 µV | > 10 GΩ | 0.012% + 300 µV |
| 20.00000 V | 500 µV | 0.015% + 2.4 mV | 100 µV | 10 µV | > 10 GΩ | 0.015% + 1 mV |
| 200.0000 V | 5 mV | 0.015% + 24 mV | 1 mV | 100 µV | > 10 GΩ | 0.015% + 10 mV |
| 1000.000 V | 50 mV | 0.02% + 100 mV | 20 mV | 10 mV | > 10 GΩ | 0.015% + 50 mV |

Temperature Coefficient ± (0.15 × accuracy specification)/°C, 0 °C to 18 °C and 28 °C to 50 °C

Current Specifications ^{1, 2}

| Range ⁴ | Source | | | Measure ³ | | |
|--------------------------|------------|--|-----------------------|----------------------|----------------|---|
| | Resolution | Accuracy ⁵ 23 °C ± 5 °C, 1 Year ±(% setting + amps) | Noise (RMS) <10 Hz | Resolution | Voltage Burden | Accuracy 23 °C ± 5 °C, 1 Year ±(% reading + amps) |
| 10.00000 nA ⁶ | 500 fA | 0.100% + 200 pA | 500 fA | 10 fA | < 100 µV | 0.10% + 250 pA |
| 100.0000 nA ⁶ | 5 pA | 0.060% + 250 pA | 500 fA | 100 fA | < 100 µV | 0.060% + 300 pA |
| 1.000000 µA | 50 pA | 0.025% + 400 pA | 5 pA | 1 pA | < 100 µV | 0.025% + 300 pA |
| 10.00000 µA | 500 pA | 0.025% + 1.5 nA | 40 pA | 10 pA | < 100 µV | 0.025% + 700 pA |
| 100.0000 µA | 5 nA | 0.020% + 15 nA | 400 pA | 100 pA | < 100 µV | 0.02% + 6 nA |
| 1.000000 mA | 50 nA | 0.020% + 150 nA | 5 nA | 1 nA | < 100 µV | 0.02% + 60 nA |
| 10.00000 mA | 500 nA | 0.020% + 1.5 µA | 40 nA | 10 nA | < 100 µV | 0.02% + 600 nA |
| 100.0000 mA | 5 µA | 0.025% + 15 µA | 100 nA | 100 nA | < 100 µV | 0.025% + 6 µA |
| 1.000000 A | 50 µA | 0.067% + 900 µA | 10 µA | 1 µA | < 100 µV | 0.03% + 500 µA |

Temperature Coefficient ± (0.15 × accuracy specification)/°C, 0 °C to 18 °C and 28 °C to 50 °C

Notes

- Speed = 1 PLC.
- All specifications are guaranteed with output ON.
- Accuracies apply to 2-wire and 4-wire modes when properly zeroed. For the 200 mV and 1 A ranges, the voltage burden may exceed the specification in 2-wire mode.
- Maximum display and programming ranges are 5% overrange for voltage, except for the 1000 V range, which is 10% overrange (1100 V), and 5% overrange for current (for example, 1.05 A on the 1 A range).
- For sink mode, accuracy is ±(0.15% + offset × 4) except for 1 A range, accuracy is: ± (1.5% + offset × 8).
- Rear-panel triaxial connections only.

Resistance Measurement Accuracy (Local Or Remote Sense) ^{7, 8, 9}

| Range | Default Resolution ¹⁰ | Default Test Current | Normal Accuracy 23 °C ± 5 °C, 1 Year ± (% reading + ohms) | Enhanced Accuracy ¹¹ 23 °C ± 5 °C, 1 Year ± (% reading + ohms) |
|---------------------------------|----------------------------------|----------------------|---|---|
| < 2.000000 Ω ¹² | 1 µΩ | User-defined | Source I _{ACC} + Meas V _{ACC} | Meas I _{ACC} + Meas V _{ACC} |
| 20.00000 Ω | 10 µΩ | 100 mA | 0.098% + 0.003 Ω | 0.073% + 0.001 Ω |
| 200.0000 Ω | 100 µΩ | 10 mA | 0.077% + 0.03 Ω | 0.053% + 0.01 Ω |
| 2.000000 kΩ | 1 mΩ | 1 mA | 0.066% + 0.3 Ω | 0.045% + 0.1 Ω |
| 20.00000 kΩ | 10 mΩ | 100 µA | 0.063% + 3 Ω | 0.043% + 1 Ω |
| 200.0000 kΩ | 100 mΩ | 10 µA | 0.065% + 30 Ω | 0.046% + 10 Ω |
| 2.000000 MΩ | 1 Ω | 1 µA | 0.11% + 300 Ω | 0.049% + 100 Ω |
| 20.00000 MΩ | 10 Ω | 1 µA | 0.11% + 1 kΩ | 0.052% + 500 Ω |
| 200.0000 MΩ ¹³ | 100 Ω | 100 nA | 0.655% + 10 kΩ | 0.349% + 5 kΩ |
| > 200.0000 MΩ ^{12, 13} | — | User-defined | Source I _{ACC} + Meas V _{ACC} | Meas I _{ACC} + Meas V _{ACC} |

| | |
|--|---|
| Temperature Coefficient | $\pm (0.15 \times \text{accuracy specification})/^{\circ}\text{C}$ 0 °C to 18 °C and 28 °C to 50 °C |
| Source Current, Measure Resistance Mode | Total uncertainty = I source accuracy + V measure accuracy (4-wire remote sense) |
| Source Voltage, Measure Resistance Mode | Total uncertainty = V source accuracy + I measure accuracy (4-wire remote sense) |
| Guard Output Impedance | $\geq 300 \Omega$ typical |

Notes

7. Speed = 1 PLC.
8. All specifications are guaranteed with output ON.
9. Accuracies apply to 2-wire and 4-wire modes when properly zeroed.
10. Measure resolution 6.5 digits.
11. Source readback enabled; offset compensation on.
12. Source current, measure resistance or source voltage, measure resistance only.
13. Rear-panel triaxial connections only.

Supplemental Specifications

| | |
|---|--|
| Overrange | 105% of range for 200 mV to 200 V, source and measure ranges; 110% of range for 1000 V, source and measure ranges |
| Regulation | |
| Voltage | Line: 0.01% of range Load: 0.01% of range + 100 μV |
| Current | Line: 0.01% of range Load: 0.01% of range + 100 pA |
| Source Limits | |
| Voltage Source Current Limit | Bipolar current limit set with a single value Minimum value is 10% of range |
| Current Source Voltage Limit | Bipolar voltage limit set with a single value Minimum value is 10% of range |
| Voltage Limit/Current Limit Accuracy | Add 0.3% of range and $\pm 0.02\%$ of reading to base specification |
| Overshoot | |
| Voltage Source | < 0.1% typical Step size = Full scale, resistive load, 20 V range, 10 mA current limit |
| Current Source | < 0.1% typical Step size = Full scale, resistive load of 10 k Ω , 1 mA range, 20 V voltage limit |
| Range Change Overshoot | Overshoot into a fully resistive 100 k Ω load, 10 Hz to 20 MHz bandwidth, adjacent ranges: 250 mV typical |
| Output Settling Time | Time required to reach within 0.1% of final value: 20 V range, 100 mA current limit: < 200 μs typical |
| Maximum Slew Rate ¹⁴ | 0.2 V/ μs , 200 V range, 100 mA limit into a 2 k Ω load (typical) 0.5 V/ μs , 1000 V range, 10 mA limit into a 100 k Ω load (typical) |
| Overvoltage Protection | User-selectable values, 10% tolerance; factory default = none |
| Voltage Source Noise | 10 Hz to 20 MHz (RMS): 4 mV typical into a resistive load |
| Common Mode Voltage | 250 V DC |
| Common Mode Isolation | > 1 G Ω , < 1000 pF |

Notes

14. High capacitance mode off.

Noise Rejection (typical)

| NPLC | NMRR | CMRR |
|---|-------|---------|
| 0.01 | — | 60 dB |
| 0.1 | — | 60 dB |
| 1 | 60 dB | 100 dB* |
| * Except 10 nA and 100 nA current ranges ~90 dB | | |

Load Impedance

Normal Mode 20 nF typical

High-Capacitance Mode Stable into 1 μ F typical (specification only valid for ranges $\geq 100 \mu$ A)

Maximum Voltage Drop Between Force and Sense Terminals

5 V

Maximum Sense Lead Resistance 1 M Ω for rated accuracySense Input Impedance > 10 G Ω Guard Offset Voltage < 300 μ V typicalSystem Measurement Speeds ¹⁵

Reading rates (readings per second) typical for 60 Hz (50 Hz), script (TSP) programmed

| NPLC | Trigger Origin | Measure to Memory | Measure to GPIB | Measure to USB | Measure to LAN | Source Measure Sweep to Memory | Source measure sweep to GPIB | Source Measure Sweep to USB | Source Measure Sweep to LAN |
|------|----------------|-------------------|-----------------|----------------|----------------|--------------------------------|------------------------------|-----------------------------|-----------------------------|
| 0.01 | Internal | 3150 (2800) | 2760 (2570) | 2825 (2570) | 2740 (2530) | 1710 (1620) | 1620 (1540) | 1630 (1540) | 1620 (1540) |
| 0.01 | External | 2170 (2050) | 2120 (2003) | 2170 (2010) | 2100 (1990) | 1670 (1590) | 1580 (1500) | 1590 (1510) | 1580 (1510) |
| 0.10 | Internal | 540 (460) | 530 (450) | 530 (450) | 530 (450) | 470 (410) | 460 (400) | 470 (400) | 470 (400) |
| 0.10 | External | 500 (430) | 490 (420) | 500 (425) | 480 (420) | 450 (400) | 460 (390) | 460 (390) | 410 (350) |
| 1.00 | Internal | 59 (49) | 58 (49) | 59 (49) | 59 (49) | 58 (48) | 58 (48) | 58 (48) | 57 (48) |
| 1.00 | External | 58 (48) | 57 (48) | 58 (48) | 58 (48) | 57 (48) | 57 (48) | 57 (48) | 55 (48) |

Reading rates (readings per second) typical for 60 Hz (50 Hz), SCPI programmed ¹⁶

| NPLC | Trigger Origin | Measure to Memory | Measure to GPIB | Measure to USB | Measure to LAN | Source Measure Sweep to memory | Source Measure Sweep to GPIB | Source Measure Sweep to USB | Source Measure Sweep to LAN |
|------|----------------|-------------------|-----------------|----------------|----------------|--------------------------------|------------------------------|-----------------------------|-----------------------------|
| 0.01 | Internal | 3040 (2800) | 3000 (2760) | 3000 (2760) | 3010 (2710) | 1710 (1630) | 1610 (1544) | 1440 (1380) | 1690 (1590) |
| 0.01 | External | 2320 (2165) | 2290 (2140) | 2340 (2150) | 2290 (2130) | 1680 (1590) | 1560 (1525) | 1410 (1360) | 1660 (1560) |
| 0.10 | Internal | 540 (460) | 540 (450) | 540 (460) | 540 (450) | 470 (410) | 470 (410) | 450 (390) | 470 (410) |
| 0.10 | External | 510 (440) | 510 (430) | 510 (440) | 510 (430) | 470 (400) | 470 (400) | 450 (390) | 470 (400) |
| 1.00 | Internal | 59 (49) | 59 (49) | 59 (49) | 59 (49) | 58 (48) | 58 (48) | 57 (48) | 58 (48) |
| 1.00 | External | 58 (49) | 58 (49) | 58 (49) | 58 (49) | 58 (48) | 58 (48) | 57 (47) | 58 (48) |

Notes

15. Reading rates applicable for voltage or current measurements, autozero off, autorange off, filter off, binary reading format, and source readback off.

16. SCPI programming mode.

General Characteristics

(Default mode unless specified)

| | |
|--|---|
| Factory Default Standard Power-Up Setting | SCPI mode |
| Source Output Modes | Fixed DC level Memory/configuration list (mixed function) Stair (linear and logarithmic) |
| Memory Buffer | >5,000,000 readings with selected measured values and timestamp |
| Real-Time Clock | Lithium battery backup (more than 3 years of battery life) |
| Remote Interfaces | GPIB: IEEE Std 488.1 compliant; supports IEEE Std 488.2 common commands and status model topology USB device (rear panel, type B): 2.0 full-speed USBTMC USB host (front panel, type A): USB 2.0, support for flash drives, FAT32 Ethernet: RJ-45 connector, 10/100 BT |
| IP Configuration | Static or DHCP |
| Expansion Interface | The TSP-Link® expansion interface allows TSP-enabled instruments to trigger and communicate with each other |
| LXI Compliance | LXI version 1.4 Core 2011 |
| TSP Mode | Embedded Test Script Processor (TSP) accessible from any host interface |
| Display | Five-inch capacitive touch, color TFT WVGA (800 × 480) with LED backlight |
| Input Signal Connections | Front: Banana. Rear: High-voltage triaxial |
| Programmability | SCPI or TSP command sets |
| Interlock | Active high-input |
| Digital I/O | Lines: Six input/output, user-defined, for digital I/O or triggering Connector: 9-pin female D Input Signal Levels: 0.7 V (maximum logic low), 3.7 V (minimum logic high) Input Voltage Limits: –0.25 V (absolute minimum), +5.25 V (absolute maximum) Maximum Source Current: +2.0 mA at > 2.7 V (per pin) Maximum Sink Current: –50 mA at 0.7 V (per pin, solid-state fuse protected) 5 V Power Supply Pin: Limited to 500 mA at > 4 V (solid-state fuse protected) Handler: User-definable start of test, end of test, four category bits |
| Cooling | Forced air, variable speed |
| Overtemperature Protection | Internally sensed temperature overload puts instrument in standby mode |
| Power Supply | 100 VRMS to 240 VRMS, 50 Hz or 60 Hz (automatically detected at power up) |
| VA Rating | 220 VA maximum |
| Altitude | Maximum 2000 meters (6562 feet) above sea level |
| EMC | Conforms to European Union EMC Directive |
| Safety | NRTL listed to UL61010-1 and UL61010-2-30; conforms to European Union Low Voltage Directive |
| RoHS | Conforms to European Union Restriction on Hazardous Substances Directive |
| Vibration | MIL-PRF-28800F Class 3 Random |
| Warm up | One hour to rated accuracies |

| | |
|--------------------|--|
| Dimensions | With handle and bumpers: 106 mm × 255 mm × 425 mm (4.18 in. high × 10.05 in. wide × 16.75 in. deep) |
| | Without handle and bumpers: 88 mm × 213 mm × 403 mm (3.46 in. high × 8.39 in. wide × 15.87 in. deep) |
| Weight | With handle and bumpers: 4.54 kg (10 lb) |
| | Without handle and bumpers: 4.08 kg (9.0 lb) |
| Environment | Operating: 0 °C to 50 °C, 70% relative humidity up to 35 °C; derate 3% relative humidity/°C, 35 °C to 50 °C |
| | Storage: –25 °C to 65 °C |
| | Pollution Category: 2 |

SourceMeter® is a registered trademark of Keithley Instruments LLC. All other trademarks are the property of their respective owners.

Supplied Accessories

| | |
|------------------|---|
| 8608 | High Performance Test Leads |
| USB-B-1 | USB Cable, Type A to Type B, 1 m (3.3 ft) |
| CS-1616-3 | Safety Interlock Mating Connector |
| 17469460X | TSP-Link/Ethernet Cable |
| | 2470 QuickStart Guide |
| | Test Script Builder Software (available at www.tektronix.com) |
| | LabVIEW and IVI Drivers (available at www.tektronix.com) |

Available Accessories

Test Leads and Probes

| | |
|-------------|-------------------------------------|
| 8605 | High Performance Modular Test Leads |
| 8606 | High Performance Modular Probe Kit |
| 8608 | High Performance Test Leads |

Cables, Connectors, Adapters

| | |
|----------------------|---|
| TRX-1100V-BAN | HV Triax to Banana Adapter. Converts the 4 triax connectors on the rear panel to 5 banana jacks |
| TRX-1100V-* | 3-slot HV Low Noise Triax Cable (0.5 m, 1 m, 2 m, 3 m lengths available) |
| 8607 | 2-wire, 1000 V Banana Cables, 1 m (3.3 ft) |
| CS-1616-3 | Safety Interlock Mating Connector |

Communication Interfaces & Cables

| | |
|--------------------|---|
| 7007-1 | Shielded GPIB Cable, 1 m (3.3 ft) |
| 7007-2 | Shielded GPIB Cable, 2 m (6.6 ft) |
| 17469460X | TSP-Link Ethernet Cable |
| KPCI-488LPA | IEEE-488 Interface for PCI Bus |
| KUSB-488B | IEEE-488 USB-to-GPIB Interface Adapter |
| USB-B-1 | USB Cable, Type A to Type B, 1 m (3.3 ft) |

Triggering and Control

| | |
|------------|---|
| 2450-TLINK | DB-9 to Trigger Link Connector Adapter |
| 8501-1 | Trigger Link Cable, DIN-to-DIN, 1 m (3.3 ft.) |
| 8501-2 | Trigger Link Cable, DIN-to-DIN, 2 m (6.6 ft.) |

Rack Mount Kits

| | |
|---------|--|
| 4299-8 | Single Fixed Rack Mount Kit |
| 4299-9 | Dual Fixed Rack Mount Kit |
| 4299-10 | Dual Fixed Rack Mount Kit. Mount one 2450 and one Series 26xxB |
| 4299-11 | Dual Fixed Rack Mount Kit. Mount one 2450 and one Series 2400, Series 2000, etc. |

Available Services

| | |
|-----------------|---|
| 2470-3Y-EW | 1-year factory warranty extended to 3 years from date of shipment |
| 2470-5Y-EW | 1-year factory warranty extended to 5 years from date of shipment |
| C/2470-3Y-17025 | KeithleyCare® 3 Year ISO 17025 Calibration Plan |
| C/2470-3Y-DATA | KeithleyCare 3 Year Calibration w/Data Plan |
| C/2470-3Y-STD | KeithleyCare 3 Year STD Calibration Plan |
| C/2470-5Y-17025 | KeithleyCare 5 Year ISO 17025 Calibration Plan |
| C/2470-5Y-DATA | KeithleyCare 5 Year Calibration w/Data Plan |
| C/2470-5Y-STD | KeithleyCare 5 Year STD Calibration Plan |
| C/NEW DATA | Calibration Data for New Units |
| C/NEW DATA ISO | ISO-17025 Calibration Data for New Units |

Ordering Information

| | |
|------|--|
| 2470 | 1000 V, 1 A, 20 W SourceMeter SMU Instrument |
|------|--|

Warranty Information

| | |
|--------------------------|--|
| Warranty Summary | This section summarizes the warranties of the 2470. For complete warranty information, refer to the Tektronix warranty page at https://www.tek.com/service/warranties/warranty-2 . Any portion of the product that is not manufactured by Keithley is not covered by this warranty and Keithley will have no duty to enforce any other manufacturer's warranties. |
| Hardware Warranty | Keithley warrants the Keithley manufactured portion of the hardware for a period of one year from defects in materials or workmanship; provided that such defect has not been caused by use of the Keithley hardware which is not in accordance with the hardware instructions. The warranty does not apply upon any modification of Keithley hardware made by the customer or operation of the hardware outside the environmental specifications. |
| Software Warranty | Keithley warrants for the Keithley produced portion of the software or firmware will conform in all material respects with the published specifications for a period of ninety (90) days; provided the software is used on the product for which it is intended in accordance with the software instructions. Keithley does not warrant that operation of the software will be uninterrupted or error-free, or that the software will be adequate for the customer's intended application. The warranty does not apply upon any modification of the software made by the customer. |

Contact Information:

Australia* 1 800 709 465
Austria 00800 2255 4835
Balkans, Israel, South Africa and other ISE Countries +41 52 675 3777
Belgium* 00800 2255 4835
Brazil +55 (11) 3759 7627
Canada 1 800 833 9200
Central East Europe / Baltics +41 52 675 3777
Central Europe / Greece +41 52 675 3777
Denmark +45 80 88 1401
Finland +41 52 675 3777
France* 00800 2255 4835
Germany* 00800 2255 4835
Hong Kong 400 820 5835
India 000 800 650 1835
Indonesia 007 803 601 5249
Italy 00800 2255 4835
Japan 81 (3) 6714 3010
Luxembourg +41 52 675 3777
Malaysia 1 800 22 55835
Mexico, Central/South America and Caribbean 52 (55) 56 04 50 90
Middle East, Asia, and North Africa +41 52 675 3777
The Netherlands* 00800 2255 4835
New Zealand 0800 800 238
Norway 800 16098
People's Republic of China 400 820 5835
Philippines 1 800 1601 0077
Poland +41 52 675 3777
Portugal 80 08 12370
Republic of Korea +82 2 565 1455
Russia / CIS +7 (495) 6647564
Singapore 800 6011 473
South Africa +41 52 675 3777
Spain* 00800 2255 4835
Sweden* 00800 2255 4835
Switzerland* 00800 2255 4835
Taiwan 886 (2) 2656 6688
Thailand 1 800 011 931
United Kingdom / Ireland* 00800 2255 4835
USA 1 800 833 9200
Vietnam 12060128

*** European toll-free number. If not accessible, call: +41 52 675 3777**



Find more valuable resources at TEK.COM

Copyright © Tektronix. All rights reserved. Tektronix products are covered by U.S. and foreign patents, issued and pending. Information in this publication supersedes that in all previously published material. Specification and price change privileges reserved. TEKTRONIX and TEK are registered trademarks of Tektronix, Inc. All other trade names referenced are the service marks, trademarks or registered trademarks of their respective companies.
042419.SBG 1KW-61523-0



Данный компонент на территории Российской Федерации

Вы можете приобрести в компании MosChip.

Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

<http://moschip.ru/get-element>

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

Офис по работе с юридическими лицами:

105318, г.Москва, ул.Щербаковская д.3, офис 1107, 1118, ДЦ «Щербаковский»

Телефон: +7 495 668-12-70 (многоканальный)

Факс: +7 495 668-12-70 (доб.304)

E-mail: info@moschip.ru

Skype отдела продаж:

moschip.ru

moschip.ru_4

moschip.ru_6

moschip.ru_9